Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/630,102	ZHU ET AL.
Examiner	Art Unit
Jenna-Leigh Befumo	1771

SEARCHED						
	SEARCHED					
Class	Subclass	Date	Examiner			
442	189, 197, 301, 302, 308, 310,	8/15/2005	JLB			
	414, 415					
428	920,921					
57	252, 255					
	257					
		•				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
Inventor Search		8/18/2005	JLB	
Text Search	•	8/18/2005	JLB	
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